

60V N-Channel Enhancement Mode MOSFET

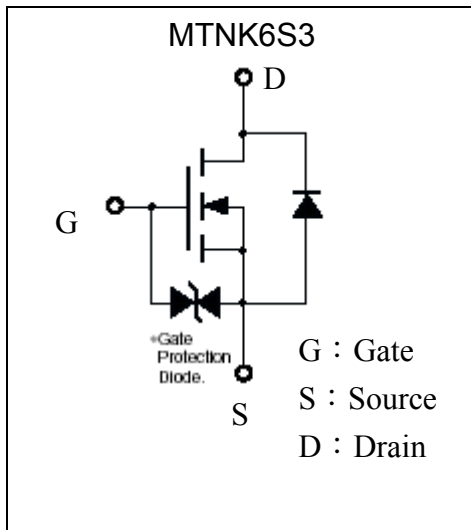
MTNK6S3

BV_{DSS}	60V
$I_D@V_{GS}=10V, T_A=25^\circ C$	0.24A
$R_{DS(on)(MAX)}@V_{GS}=10V, I_D=0.5A$	1.1 Ω (typ.)
$R_{DS(on)(MAX)}@V_{GS}=4.5V, I_D=0.2A$	1.3 Ω (typ.)

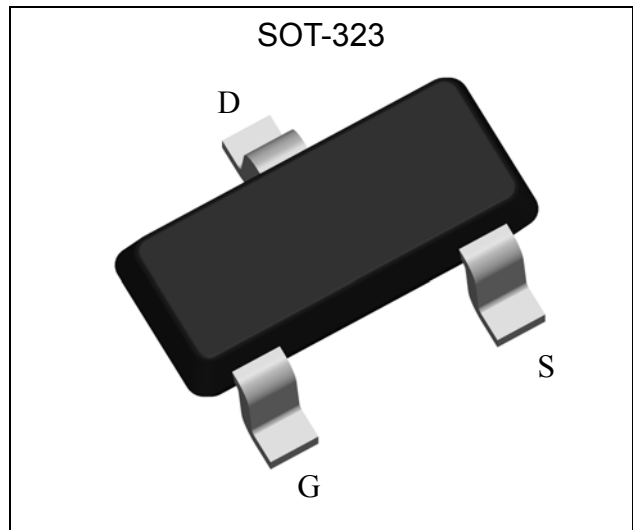
Features

- Simple drive requirement
- Small package outline
- ESD protected gate, $\geq 2kV$ (HBM)
- Pb-free lead plating and halogen-free package

Symbol

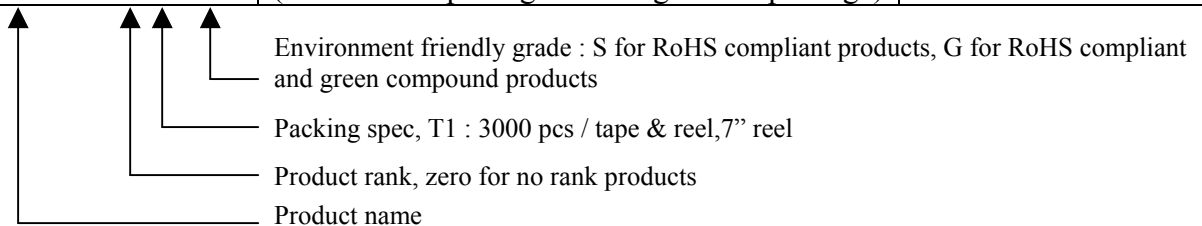


Outline



Ordering Information

Device	Package	Shipping
MTNK6S3-0-T1-G	SOT-323 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel





Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V _{DS}	60	V
Gate-Source Voltage	V _{GS}	±20	
Continuous Drain Current @V _{GS} =10V, T _A =25°C (Note 3)	I _D	0.24	A
Continuous Drain Current @V _{GS} =10V, T _A =70°C (Note 3)		0.19	
Pulsed Drain Current (Notes 1, 2)	I _{DM}	0.96	
ESD susceptibility (Note 4)	V _{ESD}	2000	V
Maximum Power Dissipation@ T _A =25°C (Note 3)	P _D	0.2	W
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+150	°C

Thermal Performance

Parameter	Symbol	Limit	Unit
Thermal Resistance, Junction-to-Ambient, max (Note 3)	R _{θJA}	625	°C/W
Thermal Resistance, Junction-to-Case, max	R _{θJC}	250	

- Note : 1. Pulse width limited by maximum junction temperature.
 2. Pulse width ≤ 300μs, duty cycle ≤ 2%.
 3. Surface mounted on copper pad of FR-4 board with minimum footprint, 2 oz. copper.
 4. Human body model, 1.5kΩ in series with 100pF

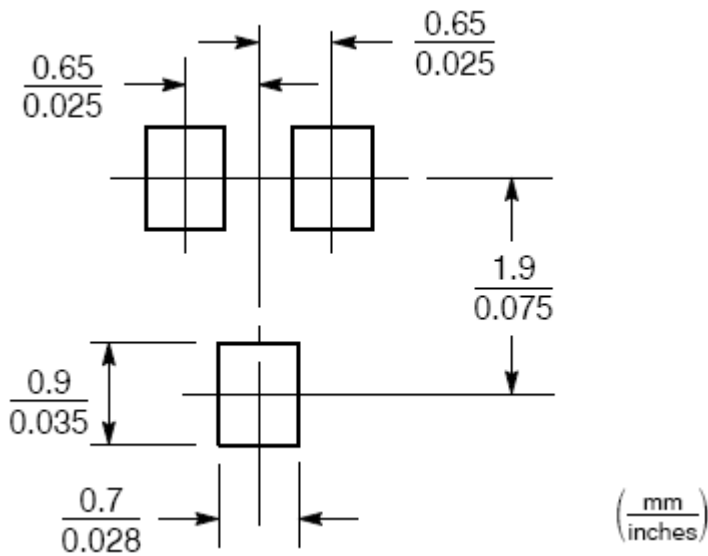
Electrical Characteristics (Tj=25°C, unless otherwise noted)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	60	-	-	V	V _{GS} =0V, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	0.06	-	V/°C	Reference to 25°C, I _D =250μA
V _{GS(th)}	1	-	2.5	V	V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±10	μA	V _{GS} =±16V, V _{DS} =0V
I _{DSS}	-	-	1		V _{DS} =60V, V _{GS} =0V
	-	-	10		V _{DS} =48V, V _{GS} =0V (T _j =70°C)
*R _{D(S)ON}	-	1.1	2.5	Ω	I _D =0.5A, V _{GS} =10V
	-	1.3	3		I _D =0.2A, V _{GS} =4.5V
*G _{FS}	-	0.25	-	S	V _{DS} =10V, I _D =0.1A
Dynamic					
C _{iss}	-	23	-	pF	V _{DS} =30V, V _{GS} =0V, f=1MHz
C _{oss}	-	7	-		
C _{rss}	-	1	-		
t _{d(ON)}	-	3.8	-	ns	V _{DS} =30V, I _D =0.5A, V _{GS} =10V, R _G =1Ω
t _r	-	15.4	-		
t _{d(OFF)}	-	9.8	-		
t _f	-	16.2	-		

Qg	-	1.6	-	nC	V _{DS} =48V, I _D =0.5A, V _{GS} =10V
Qgs	-	0.6	-		
Qgd	-	0.6	-		
Source-Drain Diode					
I _S	-	-	0.24	A	
I _{SM}	-	-	0.96		
*V _{SD}	-	0.8	1.2	V	V _{GS} =0V, I _S =0.1A
*t _{rr}	-	9.2	-	ns	I _F =0.5A, dI _F /dt=100A/μs
*Q _{rr}	-	3	-	nC	

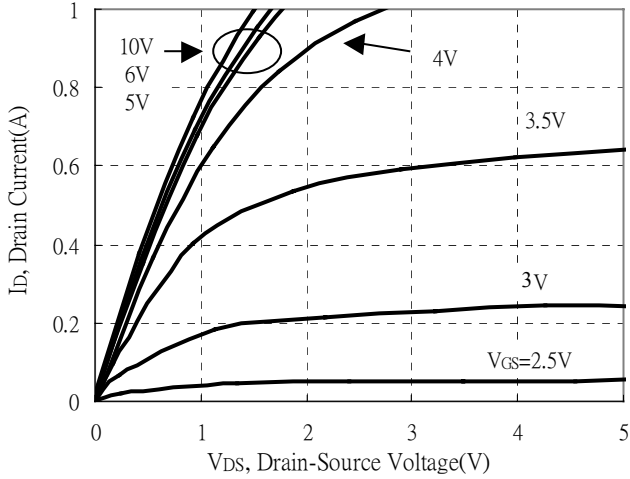
*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

Recommended Soldering Footprint

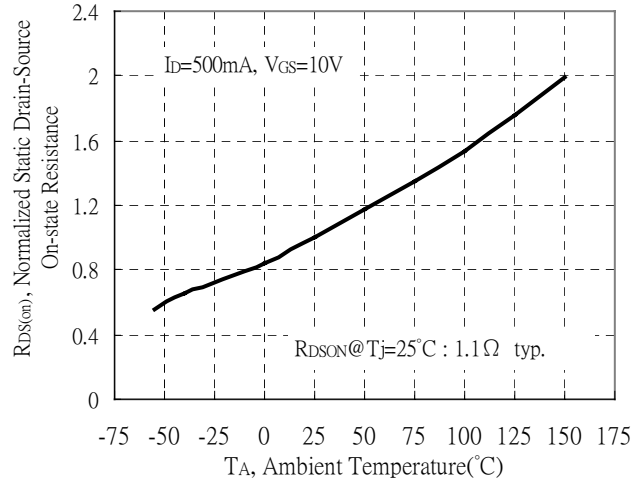


Typical Characteristics

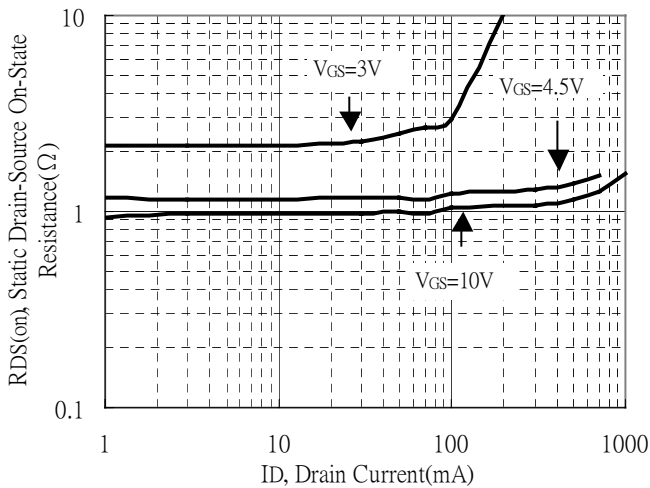
Typical Output Characteristics



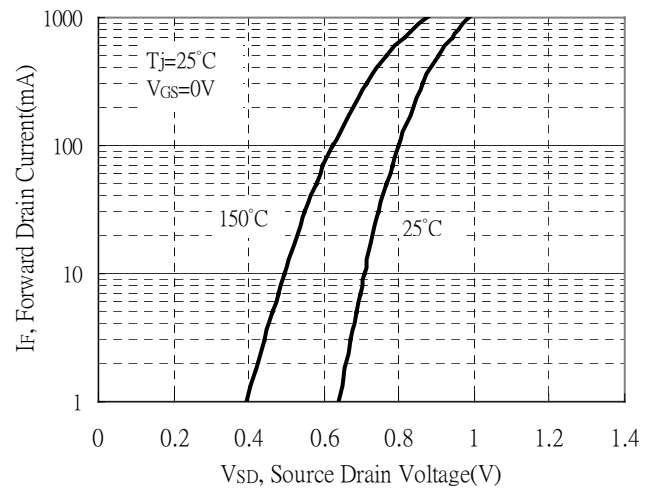
Static Drain-Source On-resistance vs Ambient Temperature



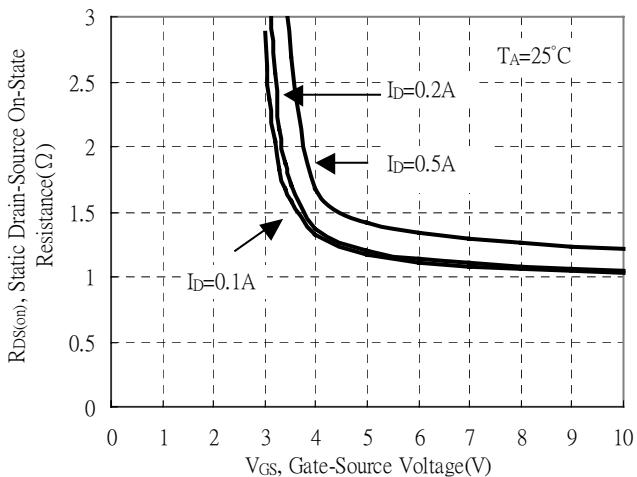
Static Drain-Source On-State resistance vs Drain Current



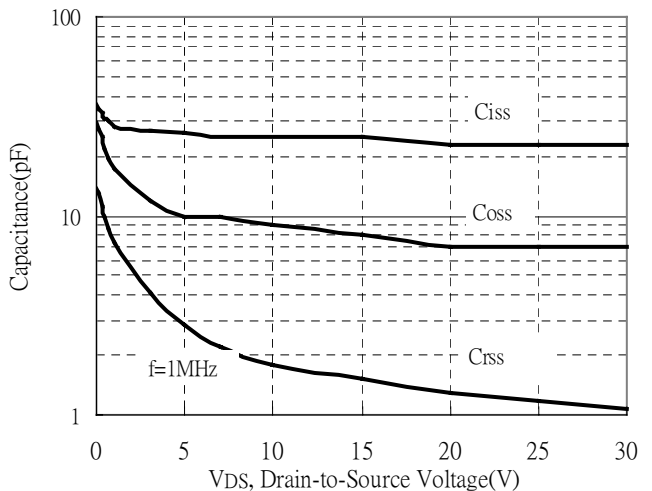
Forward Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

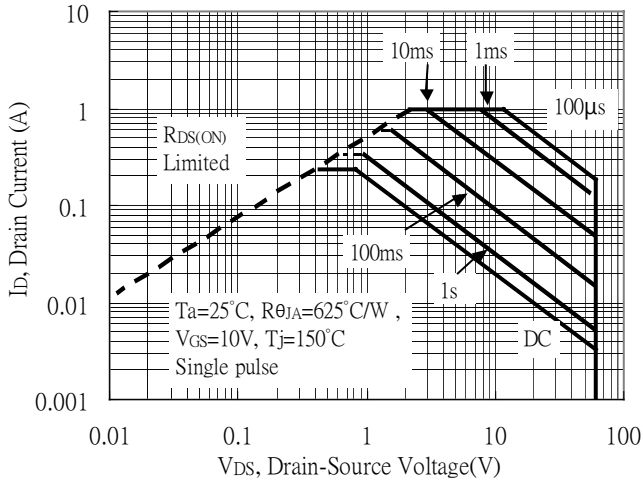


Capacitance vs Reverse Voltage

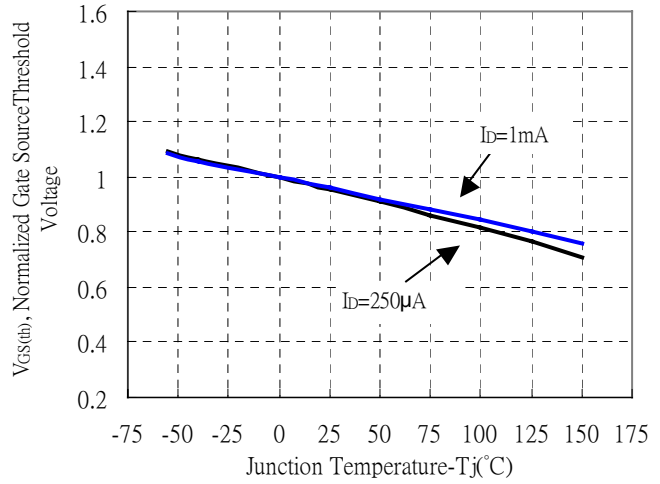


Typical Characteristics(Cont.)

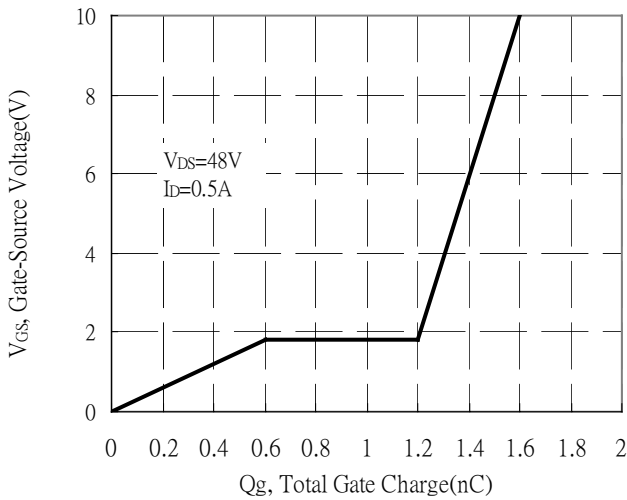
Maximum Safe Operating Area



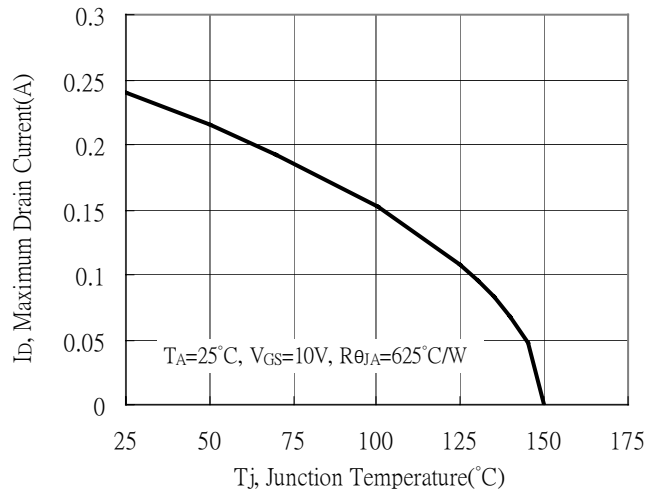
Gate Threshold Voltage vs Ambient Temperature



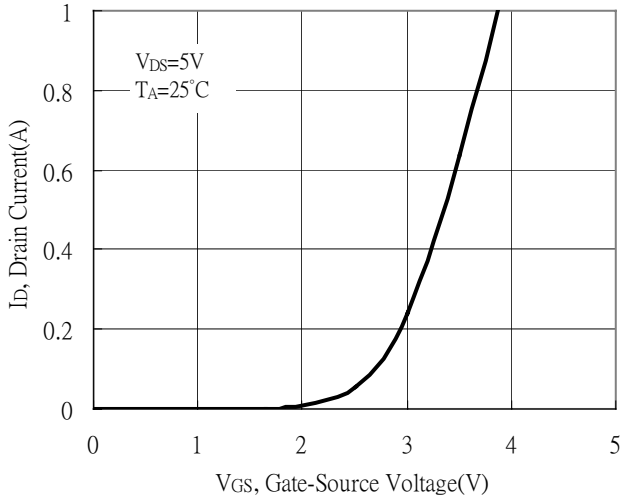
Gate Charge Characteristics



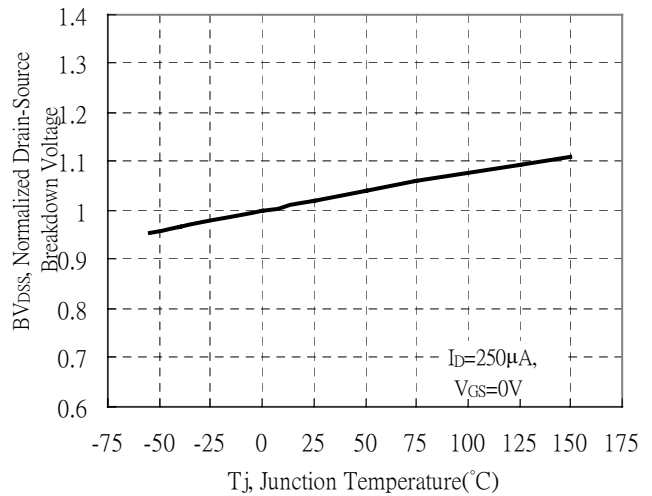
Maximum Drain Current vs Junction Temperature



Drain Current vs Gate-Source Voltage

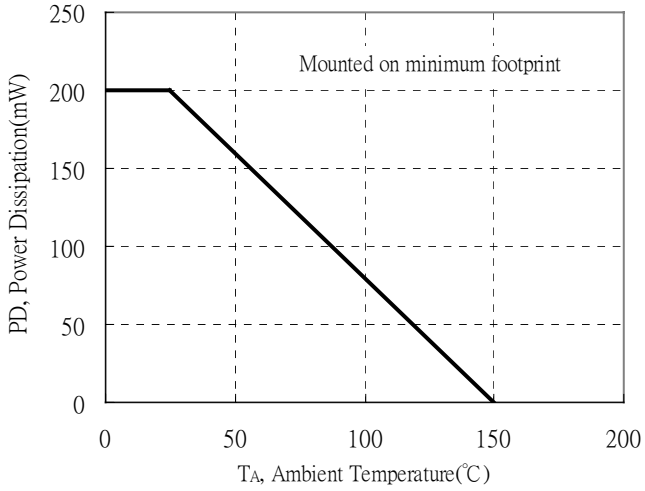


Brekdown Voltage vs Ambient Temperature

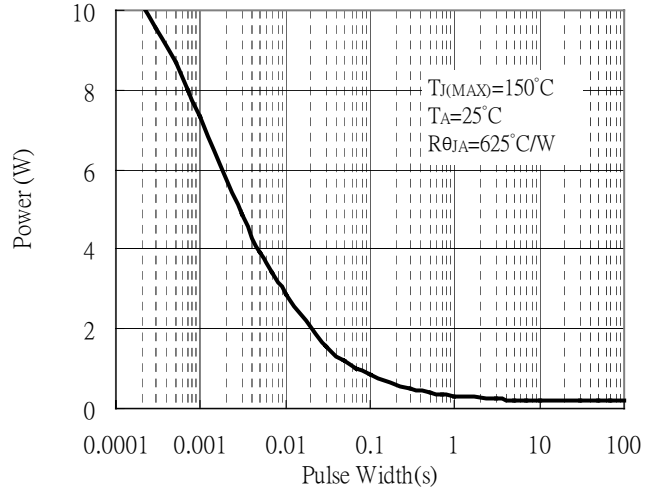


Typical Characteristics(Cont.)

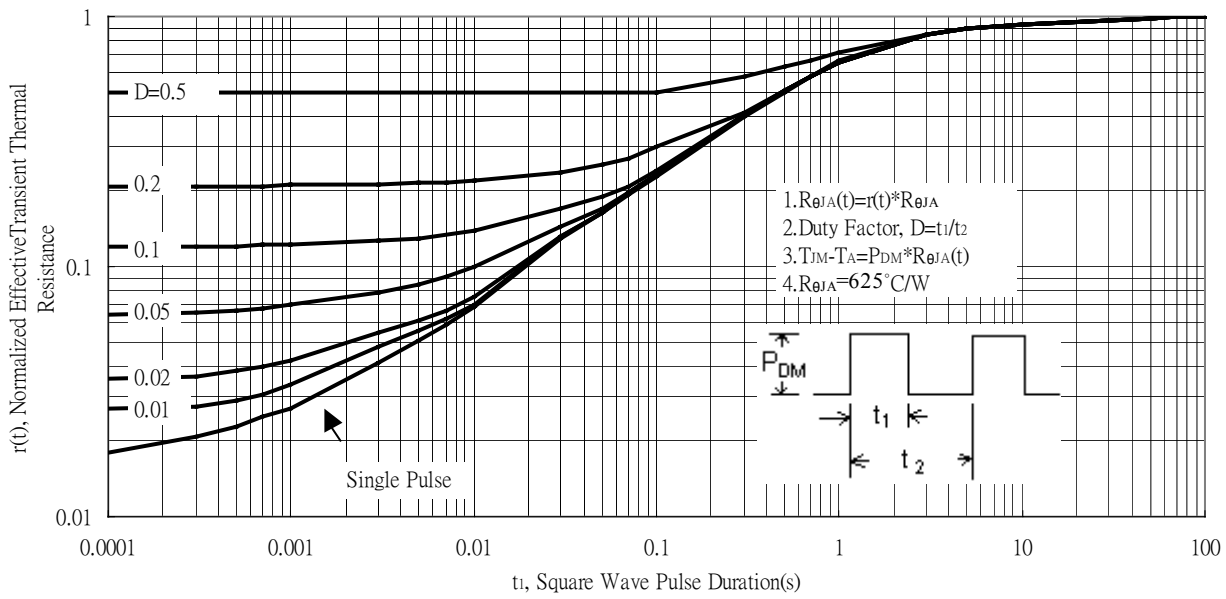
Power Derating Curve



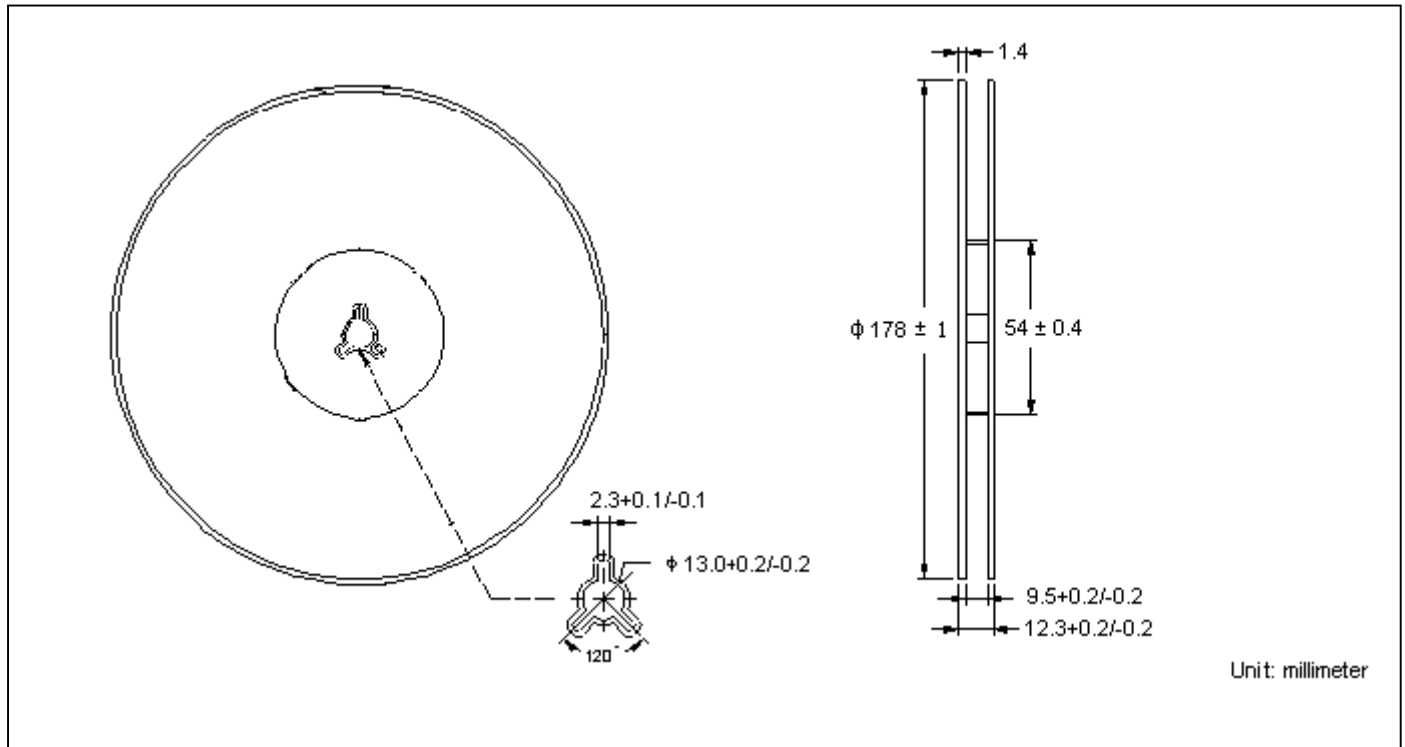
Single Pulse Power Rating, Junction to Ambient



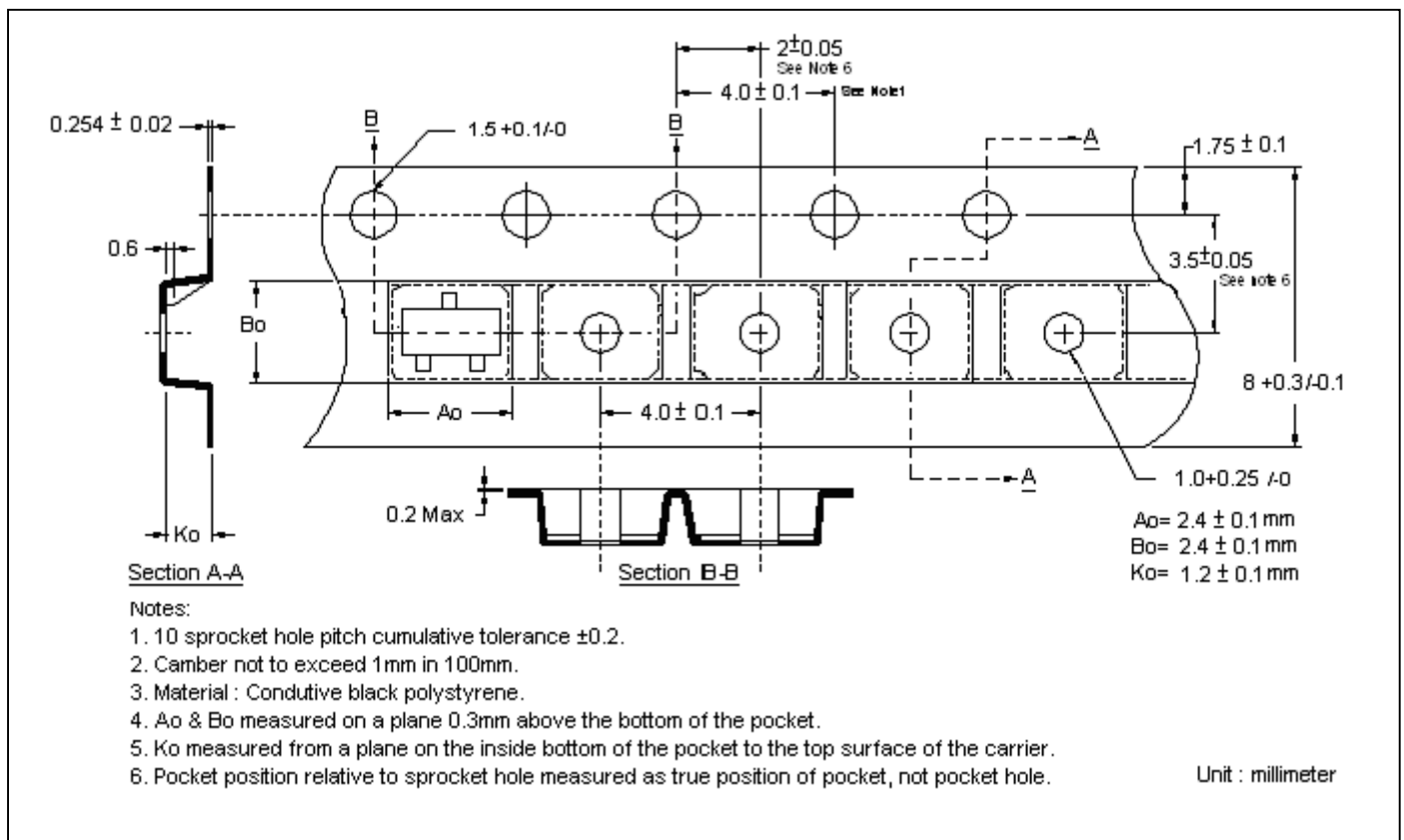
Transient Thermal Response Curves



Reel Dimension



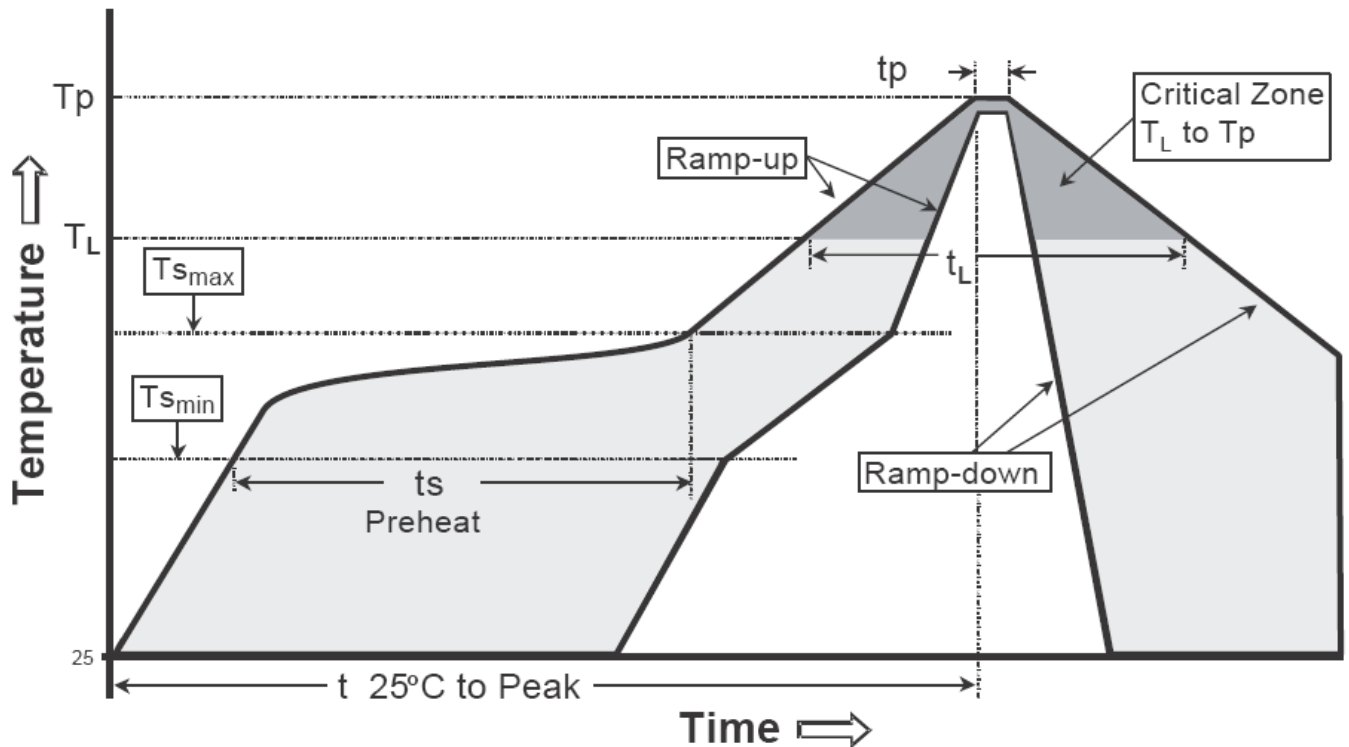
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

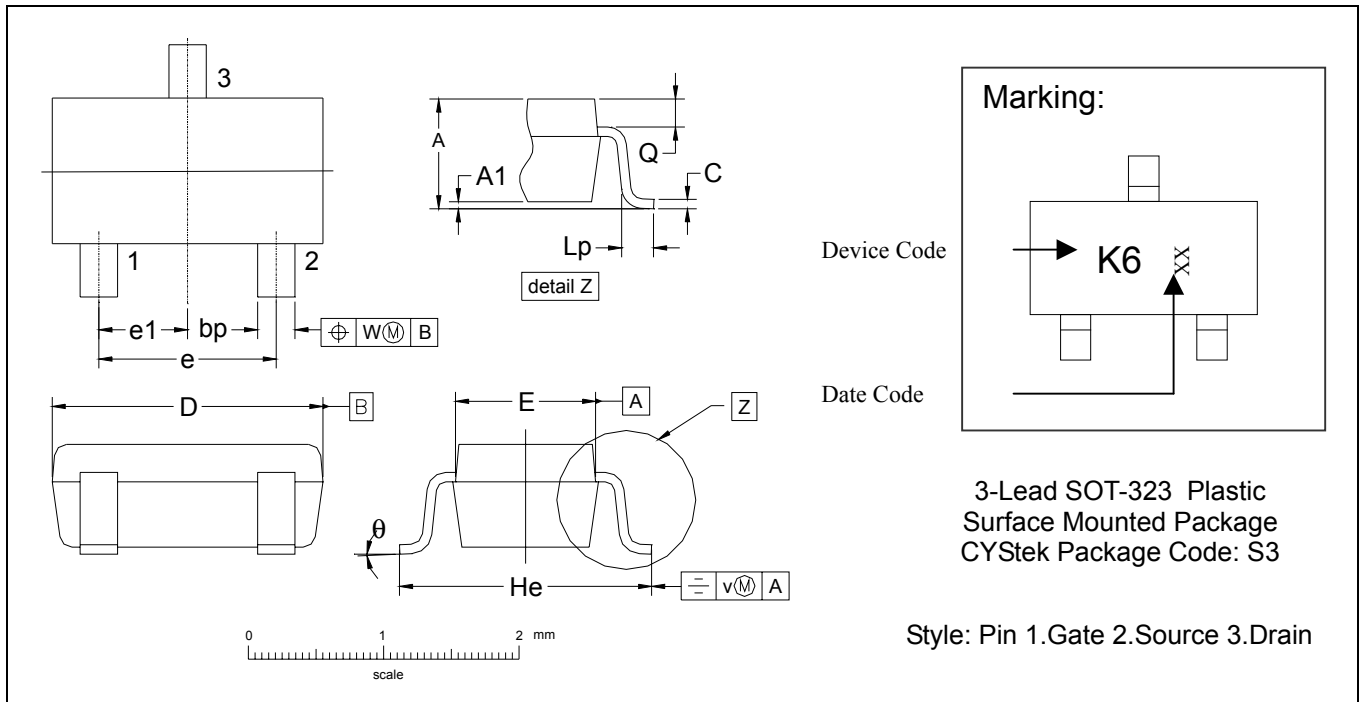
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Tsmax to Tp)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(Ts min)	100°C	150°C
-Temperature Max(Ts max)	150°C	200°C
-Time(ts min to ts max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (TL)	183°C	217°C
- Time (tL)	60-150 seconds	60-150 seconds
Peak Temperature(TP)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOT-323 Dimension



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.0315	0.0433	0.80	1.10	e1	0.0256	-	0.65	-
A1	0.0000	0.0039	0.00	0.10	He	0.0787	0.0886	2.00	2.25
bp	0.0118	0.0157	0.30	0.40	Lp	0.0059	0.0177	0.15	0.45
C	0.0039	0.0098	0.10	0.25	Q	0.0051	0.0091	0.13	0.23
D	0.0709	0.0866	1.80	2.20	v	0.0079	-	0.2	-
E	0.0453	0.0531	1.15	1.35	w	0.0079	-	0.2	-
e	0.0512	-	1.3	-	θ	-	-	10°	0°

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: Pure tin plated
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

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